

FORM PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. RUT.01-013US	APPL. NO. 09/992,486
INFORMATION DISCLOSURE STATEMENT BY APPLICANT(S)		APPLICANT Kristin J. Dana	
(Use several sheets if necessary)		FILING DATE November 14, 2001	GROUP: 2877

## U.S. PATENT DOCUMENTS

Examiner Initial		DOCUMENT NUMBER							DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>h</i>	A1	5	9	1	2	7	4	1	06/15/99	Carter et al.			
<i>h</i>	A2	5	6	3	7	8	7	3	06/10/97	Davis et al.			
<i>h</i>	A3	4	9	8	8	2	0	5	01/29/91	Snail			
<i>h</i>	A4	4	8	1	5	8	5	8	03/28/89	Snail			
<i>h</i>	A5	6	0	7	5	6	1	2	06/13/00	Mandella et al.			
<i>h</i>	A6	5	9	9	1	0	2	2	04/27/99	Buermann et al.			
<i>h</i>	A7	5	9	2	6	2	6	2	07/20/99	Jung et al.			
<i>h</i>	A8	5	8	8	9	5	9	3	03/30/99	Bareket			
<i>h</i>	A9	5	7	2	1	4	3	5	02/24/98	Troll			
<i>h</i>	A10	5	2	4	1	3	6	9	08/31/93	McNeil et al.			
<i>h</i>	A11	5	1	9	6	9	0	6	03/23/93	Stover et al.			
<i>h</i>	A12	5	1	5	5	5	5	8	10/13/92	Tannenbaum et al.			

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER							DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION YES	NO

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

<i>h</i>	C1	Nayar, Shree K. "Catadioptric Omnidirectional Camera." In IEEE Conference on Computer Vision and Pattern Recognition, Puerto Rico: 482-488 (1997).
<i>h</i>	C2	Ward, Gregory J. "Measuring and Modeling Anisotropic Reflection." Computer Graphics, 26(2): 265-272 (July 1992).

EXAMINER


DATE CONSIDERED

6/10/85

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



<b>INFORMATION DISCLOSURE STATEMENT</b>	<i>Complete if known</i>
	Application Number: 09/992,486
	Filing Date: November 14, 2001
	First Named Inventor: Dana
	Group Art Unit: 2877
	Examiner Name: Richard A. Rosenberger
SHEET 1 OF 1	Attorney Docket Number: Rut 01-013

UNITED STATES PATENT DOCUMENTS				
EXAMINER'S INITIALS	CITE NO.	PATENT NUMBER	ISSUE DATE MM-DD-YYYY	FIRST NAMED INVENTOR
		6100974	08/08/2000	Reininger

FOREIGN PATENT DOCUMENTS					
EXAMINER'S INITIALS	CITE NO.	DOCUMENT NUMBER	COUNTRY OR REGION	DATE OF PUBLICATION MM-DD-YYYY	FIRST NAMED INVENTOR OR APPLICANT

OTHER CITATIONS - NON-PATENT DOCUMENTS		
EXAMINER'S INITIALS	CITE NO.	Include name of the author (in Capital Letters), title of the article (when appropriate), title of the item(book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published

EXAMINER'S SIGNATURE		DATE CONSIDERED	6/10/05
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